

<b>Notice of References Cited</b>	Application/Control No. 09/784,221	Applicant(s)/Patent Under Reexamination LEYN, ALEXANDER I.	
	Examiner Phuong Phu	Art Unit 2631	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	IEEE, "IEEE 100 The Authoritative Dictionary of IEEE Standard Terms", Seventh Edition, Published by Standards Information Network IEEE Press, December 2000, pages 1140-1141.
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